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Your wildcard search against 10000 terms has yielded the results below.

Your result set for the last L# is incomplete.

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Terms	Documents
L8 and switch\$ adj off	10

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	DB=PGPB,USPT,USOC,EPAB,JPAB,DWPI,TDBD; PLUR=YES; OP=OR		
<u>L9</u>	L8 and switch\$ adj off	10	<u>L9</u>
<u>L8</u>	first adj microprocessor and second adj microprocessor and control adj system and fault	72	<u>L8</u>
<u>L7</u>	L6 and control adj system and fault	13	<u>L7</u>
<u>L6</u>	L4 and first adj microprocessor and second adj microprocessor	111	<u>L6</u>
<u>L5</u>	L4 and (miller-peter-john.in. or osborne-smith-andrew-charles.in. or lindsey-michael-john.in. or barnes-robert-john.in. or allen-david-john.in. ludar-smith-graham.in.)	2	<u>L5</u>
<u>L4</u>	700.clas.	51642	<u>L4</u>
<u>L3</u>	control adj system and load and first adj microprocessor and second adj microprocessor and fault and switched adj off	3	<u>L3</u>

DB=PGPB,USPT; PLUR=YES; OP=OR

L2 control adj system and load and first adj microprocessor and second adj
microprocessor and fault and switched adj off

2 L2

DB=PGPB; PLUR=YES; OP=OR

L1 control adj system and load and first adj microprocessor and second adj
microprocessor and fault and switched adj off.CLM.

1 L1

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L10 and first adj microprocessor and second adj microprocessor and control adj system and fault	2

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<u>L11</u>	L10 and first adj microprocessor and second adj microprocessor and control adj system and fault	2	<u>L11</u>
<u>L10</u>	one adj side adj6 load	6388	<u>L10</u>
<u>L9</u>	L8 and switch\$ adj off	10	<u>L9</u>
<u>L8</u>	first adj microprocessor and second adj microprocessor and control adj system and fault	72	<u>L8</u>
<u>L7</u>	L6 and control adj system and fault	13	<u>L7</u>
<u>L6</u>	L4 and first adj microprocessor and second adj microprocessor	111	<u>L6</u>
<u>L5</u>	L4 and (miller-peter-john.in. or osborne-smith-andrew-charles.in. or lindsey-michael-john.in. or barnes-robert-john.in. or allen-david-john.in. ludar-smith-graham.in.)	2	<u>L5</u>
<u>L4</u>	700.clas.	51642	<u>L4</u>

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|-----------|---|---|-----------|
| <u>L3</u> | control adj system and load and first adj microprocessor and second adj microprocessor and fault and switched adj off
<i>DB=PGPB,USPT; PLUR=YES; OP=OR</i> | 3 | <u>L3</u> |
| <u>L2</u> | control adj system and load and first adj microprocessor and second adj microprocessor and fault and switched adj off
<i>DB=PGPB; PLUR=YES; OP=OR</i> | 2 | <u>L2</u> |
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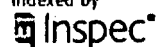
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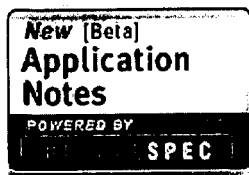

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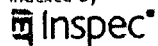
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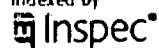
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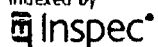
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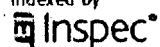
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 Nen, C.; Schmitt, W.; Karakaxis, K.; Manias, S.N.;
[Industrial Electronics, 1995. ISIE '95., Proceedings of the IEEE International S](#)
 Volume 1, 10-14 July 1995 Page(s):309 - 314 vol.1
 Digital Object Identifier 10.1109/ISIE.1995.497014
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- ☐ 2. **Universal protection and control applied to a 3-breaker transfer scheme**
 Day, T.; McCall, J.; Gomes, D.;
[Transmission and Distribution Conference, 1999 IEEE](#)
 Volume 2, 11-16 April 1999 Page(s):454 - 459 vol.2
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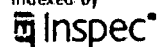
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microprocessors

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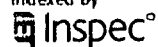
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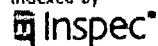
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Thompson, H.A.;
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Ming Yuan Cho; Shih Wei Gau; Cha Win Huang;
[Industrial and Commercial Power Systems Technical Conference, 2001. Conf Presented at the 2001 Annual Meeting, 2001 IEEE](#)
15-16 May 2001 Page(s):1 - 6
Digital Object Identifier 10.1109/ICPS.2001.966504
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- ☐ 2. **Effects of system architecture on safety and reliability of multiple micro systems**
Milnor, R.C.; Washington, R.S.;
[Vehicular Technology Conference, 1984. 34th IEEE](#)
Volume 34, 21-23 May 1984 Page(s):306 - 315
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- ☐ 3. **Automatic assembly for microelectronic components**
Zeungnam Bien; Sang-Rok Oh; Il-Hong Suh; Jae-Ok Kim; Young-Seok Oh;
[Control Systems Magazine, IEEE](#)
Volume 9, [Issue 4](#), June 1989 Page(s):15 - 19
Digital Object Identifier 10.1109/37.24833
[AbstractPlus](#) | Full Text: [PDF\(588 KB\)](#) IEEE JNL
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- ☐ 4. **Innovation to reality - introducing state-of-the-art protection and monito voltage switchgear**
Reber, S.; Pintar, M.; Eaves, C.;
[Cement Industry Technical Conference, 2004. IEEE-IAS/PCA](#)
25-30 April 2004 Page(s):29 - 39
[AbstractPlus](#) | Full Text: [PDF\(779 KB\)](#) IEEE CNF
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- ☐ **5. Engineering the CBTC interface with the NYCT R143 vehicle**
Schaefer, E.; Mortlock, E.;
[Railroad Conference, 2001. Proceedings of the 2001 IEEE/ASME Joint](#)
17-19 April 2001 Page(s):17 - 28
Digital Object Identifier 10.1109/RRCON.2001.921747
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Thompson, H.A.;
[Parallel Processing: Industrial and Scientific Applications, IEE Colloquium on](#)
24 May 1991 Page(s):1/1 - 1/8
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- ☐ **7. Future research investment strategies**
Looft, D.J.;
[Decision and Control including the 16th Symposium on Adaptive Processes a](#)
[on Fuzzy Set Theory and Applications, 1977 IEEE Conference on](#)
Volume 16, Part 1, Dec. 1977 Page(s):1 - 1
Digital Object Identifier 10.1109/CDC.1977.271534
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- ☐ **8. Model reference adaptive control of a thermostatic chamber**
Ciccarella, G.; Marietti, P.;
[Industrial Electronics, IEEE Transactions on](#)
Volume 36, Issue 1, Feb. 1989 Page(s):88 - 93
Digital Object Identifier 10.1109/41.20352
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